

HIGH-SPEED SWITCHING DIODE

FEATURES

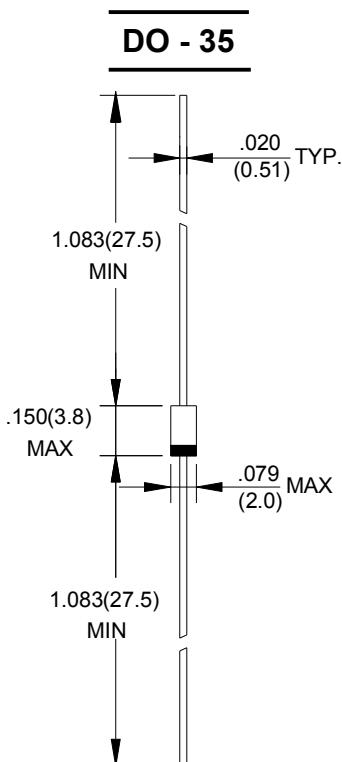
- High reliability
- High forward current capability

APPLICATIONS

- High speed switch and general purpose use in computer and industrial applications

CONSTRUCTION

- Silicon epitaxial planar



Dimensions in inches and (millimeters)

ABSOLUTE MAXIMUM RATINGS

(T_J=25°C)

Parameter	Test Conditions	Type	Symbol	Value	Unit
Repetitive peak reverse voltage			V _{RRM}	100	V
Reverse Voltage			V _R	75	V
Peak forward surge current	t _p =1uS	I _{FSM}		75	A
Forward current		I _F		75	mA
Average forward current	V _R =0	I _{FAV}		53	mA
Power dissipation		P _V		300	mW
Junction temperature		T _J			°C
Storage temperature range		T _{Stg}		-65 ~ +175	°C

MAXIMUM THERMAL RESISTANCE

(T_J=25°C)

Parameter	Test Conditions	Symbol	Value	Unit
Junction ambient	On PC board 50mm*50mm*1.6mm	R _{thJA}	500	K/W

ELECTRICAL CHARACTERISTICS

T_J=25°C

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
Forward voltage	I _F =1mA	V _F	0.54		0.62	V
	I _F =10mA	V _F	0.66		0.74	V
	I _F =50mA	V _F	0.76		0.86	V
	I _F =100mA	V _F	0.82		0.92	V
	I _F =200mA	V _F	0.87		1.0	V
Reverse current	VR=50V	I _R			100	nA
	VR=50V, T _j =150°C	I _R			100	uA
Diode capacitance	VR=0, f=1MHZ, VHF=50mA	C _D			2.5	pF
Reverse recovery time	I _F = IR=10...100mA, RL=100Ω	t _{rr}			4	ns

RATING AND CHARACTERISTIC CURVES

1N4150

HFV

FIG. 1 - MAXIMUM PERMISSIBLE CONTINUOUS FORWARD CURRENT VS. AMBIENT TEMPERATURE

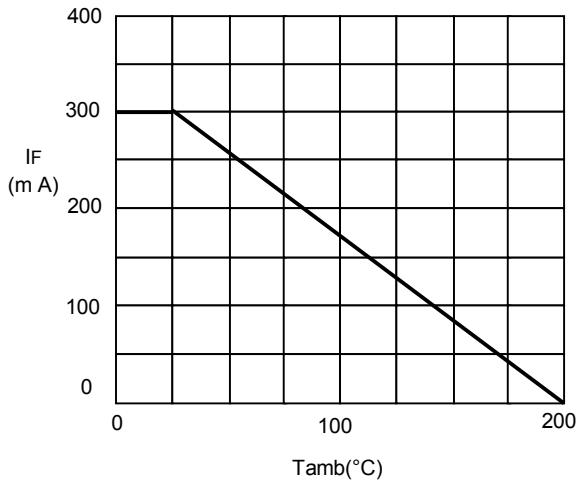


FIG. 2 - FORWARD CURRENT VS. FORWARD VOLTAGE

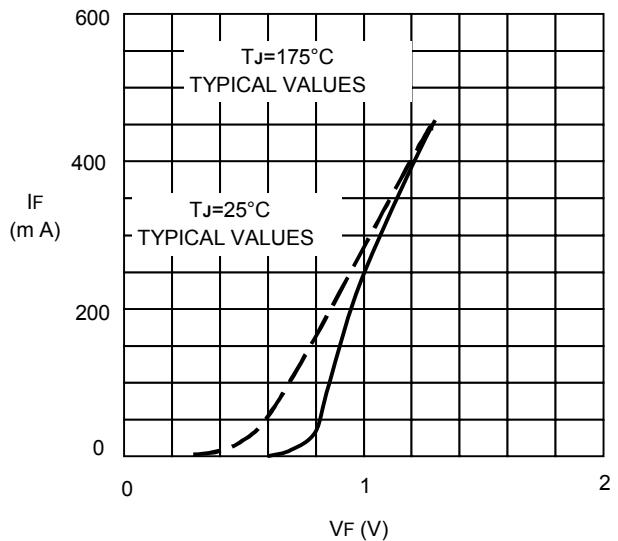


FIG.3-REVERSE CURRENT VS. JUNCTION TEMPERATURE

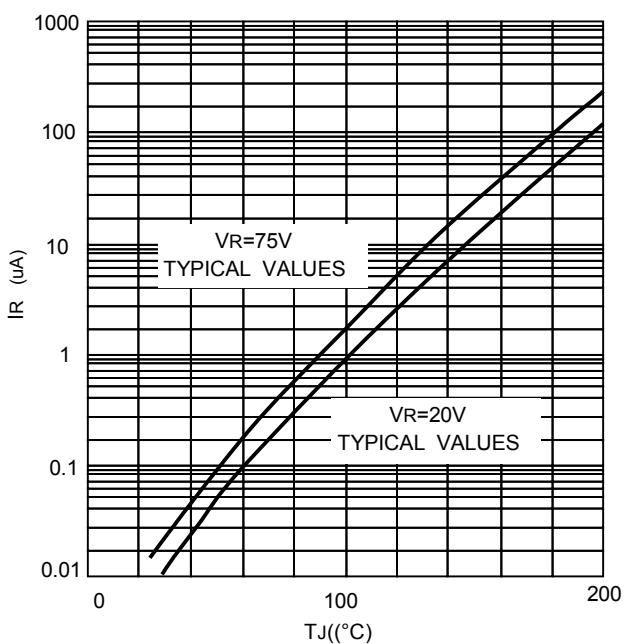


FIG. 4 - DIODE CAPACITANCE VS. REVERSE VOLTAGE (TYPICAL VALUES)

